



General Description

The IAUC100N10S5L040 use advanced SGT MOSFET technology to provide low RDS(ON), low gate charge, fast switching and excellent avalanche characteristics. This device is specially designed to get better ruggedness and suitable.

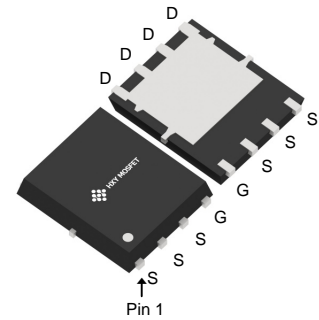
General Features

$V_{DS} = 100V$ $I_D = 120A$

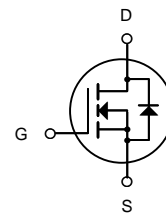
$R_{DS(ON)} < 4.4m\Omega @ V_{GS}=10V$

Applications

Consumer electronic power supply Motor control
Synchronous-rectification Isolated DC
Synchronous-rectification applications



DFN5X6-8L



N-Channel MOSFET

Package Marking and Ordering Information

| Product ID | Pack | Brand | Qty(PCS) |
|------------------|-----------|------------|----------|
| IAUC100N10S5L040 | DFN5X6-8L | HXY MOSFET | 5000 |

Absolute Maximum Ratings (T_c =25°C unless otherwise noted)

| Symbol | Parameter | Rating | Units |
|-------------------------|--|------------|-------|
| V_{DS} | Drain-Source Voltage | 100 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D @ T_C=25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ ¹ | 120 | A |
| $I_D @ T_C=100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ ¹ | 81 | A |
| I_{DM} | Pulsed Drain Current ² | 512 | A |
| EAS | Single Pulse Avalanche Energy ³ | 486 | mJ |
| I_{AS} | Avalanche Current | 67 | A |
| $P_D @ T_C=25^\circ C$ | Total Power Dissipation ⁴ | 176 | W |
| T_{STG} | Storage Temperature Range | -55 to 150 | °C |
| T_J | Operating Junction Temperature Range | -55 to 150 | °C |
| $R_{\theta JC}$ | Thermal Resistance from Junction-to-Ambient ³ | 0.8 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance Junction-Ambient ¹ | 56 | °C/W |



Electrical Characteristics (T_J = 25°C, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|-------------------------------------|--|--|------|------|------|-------|
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} =0V, I _D =250uA | 100 | --- | --- | V |
| ΔBV _{DSS} /ΔT _J | BV _{DSS} Temperature Coefficient | Reference to 25°C, I _D =1mA | --- | --- | --- | V/°C |
| R _{DS(ON)} | Static Drain-Source On-Resistance ² | V _{GS} =10V, I _D =20A | --- | 3.6 | 4.4 | mΩ |
| | | V _{GS} =4.5V, I _D =20A | --- | --- | --- | |
| V _{GS(th)} | Gate Threshold Voltage | V _{GS} =V _{DS} , I _D =250uA | 2.0 | 3.0 | 4.0 | V |
| ΔV _{GS(th)} | V _{GS(th)} Temperature Coefficient | | --- | --- | --- | mV/°C |
| I _{DSS} | Drain-Source Leakage Current | V _{DS} =80V, V _{GS} =0V, T _J =25°C | --- | --- | 1 | uA |
| | | V _{DS} =80V, V _{GS} =0V, T _J =100°C | --- | --- | 100 | |
| I _{GSS} | Gate-Source Leakage Current | V _{GS} =±20V, V _{DS} =0V | --- | --- | ±100 | nA |
| g _{fs} | Forward Transconductance | V _{DS} =5V, I _D =20A | --- | 35 | --- | S |
| R _g | Gate Resistance | V _{DS} =0V, V _{GS} =0V, f=1MHz | --- | 1.6 | --- | Ω |
| Q _g | Total Gate Charge | V _{DS} =50V, V _{GS} =10V, I _D =20A | --- | 69 | --- | nC |
| Q _{gs} | Gate-Source Charge | | --- | 24 | --- | |
| Q _{gd} | Gate-Drain Charge | | --- | 18.5 | --- | |
| T _{d(on)} | Turn-On Delay Time | V _{GS} =10V, V _{DD} =50V, R _G =3Ω, I _D =20A | --- | 18.0 | --- | ns |
| T _r | Rise Time | | --- | 23 | --- | |
| T _{d(off)} | Turn-Off Delay Time | | --- | 37 | --- | |
| T _f | Fall Time | | --- | 15.7 | --- | |
| C _{iss} | Input Capacitance | V _{DS} =50V, V _{GS} =0V, f=1MHz | --- | 4102 | --- | pF |
| C _{oss} | Output Capacitance | | --- | 592 | --- | |
| C _{rss} | Reverse Transfer Capacitance | | --- | 19.8 | --- | |

Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|-----------------|--|---|------|------|------|------|
| I _S | Continuous Source Current ^{1,5} | V _G =V _D =0V, Force Current | --- | --- | 120 | A |
| V _{SD} | Diode Forward Voltage ² | V _{GS} =0V, I _S =1A, T _J =25°C | --- | --- | 1.2 | V |

Note :

F The data is tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.

G The data is tested by pulsed pulse width ≤ 300us, duty cycle ≤ 2%

H The EAS data shows Max. rating. The test condition is T_J = 25°C, L = 3.0mH, I_{AS} = 18A, V_{GS} = 10V, V_{DD} = 50V; 100% test at L = 0.1mH, I_{AS} = 67A.

I The power dissipation is limited by 150°C junction temperature

Í The data is theoretically the same as I_{SD} and I_{DMA}. In real applications, it should be limited by total power dissipation.



Typical Characteristics

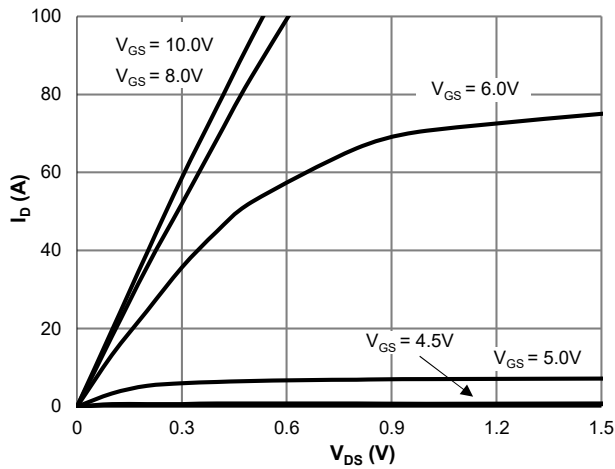


Figure 1: Saturation Characteristics

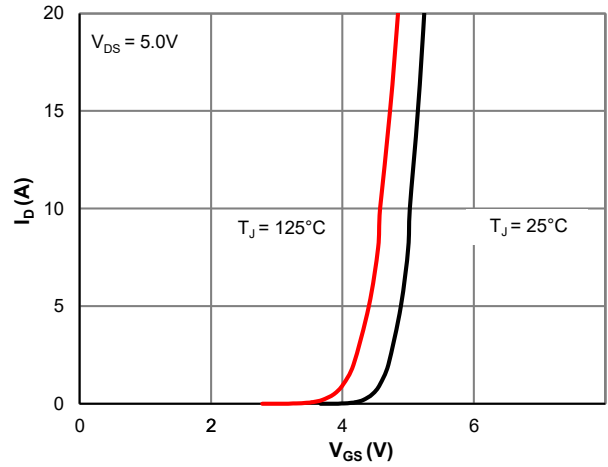


Figure 2: Transfer Characteristics

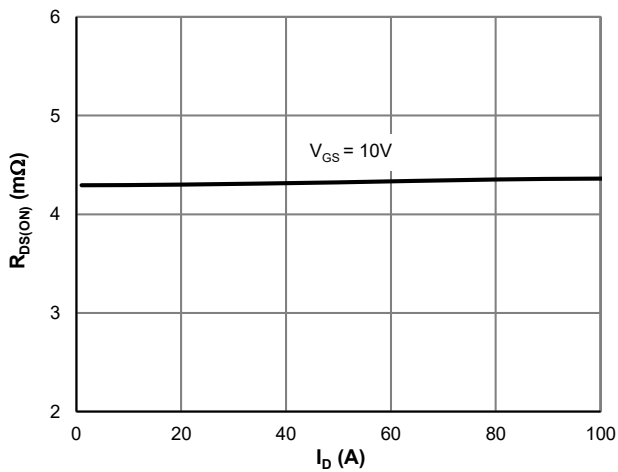


Figure 3: $R_{DS(ON)}$ vs. Drain Current

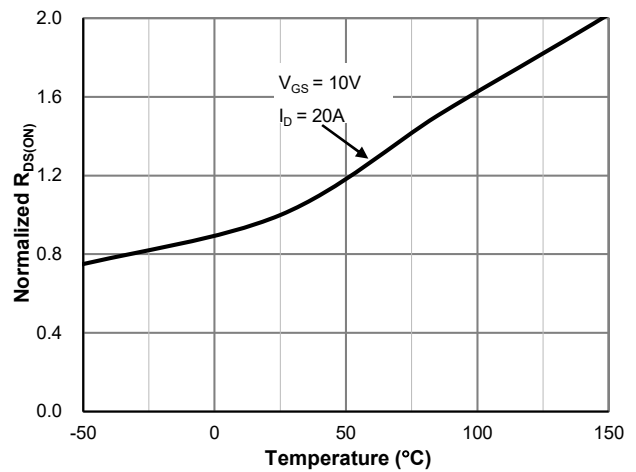


Figure 4: $R_{DS(ON)}$ vs. Junction Temperature

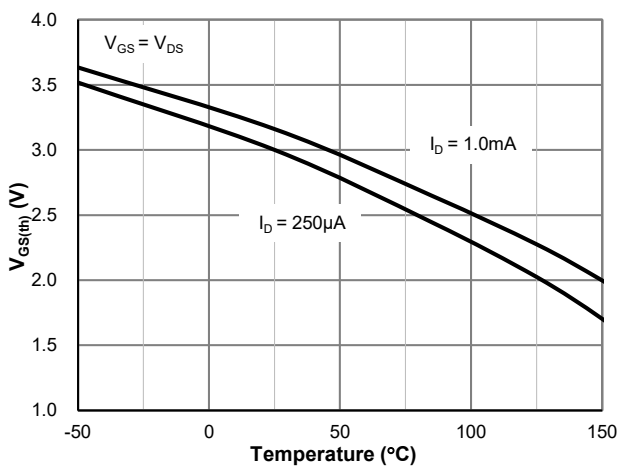


Figure 5: $V_{GS(th)}$ vs. Junction Temperature

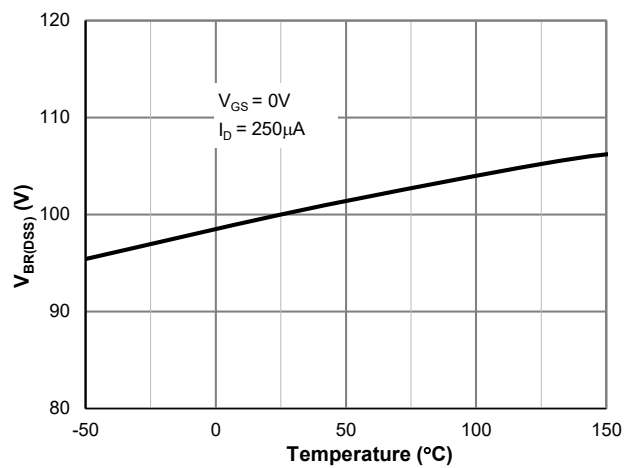


Figure 6: $V_{BR(DSS)}$ vs. Junction Temperature

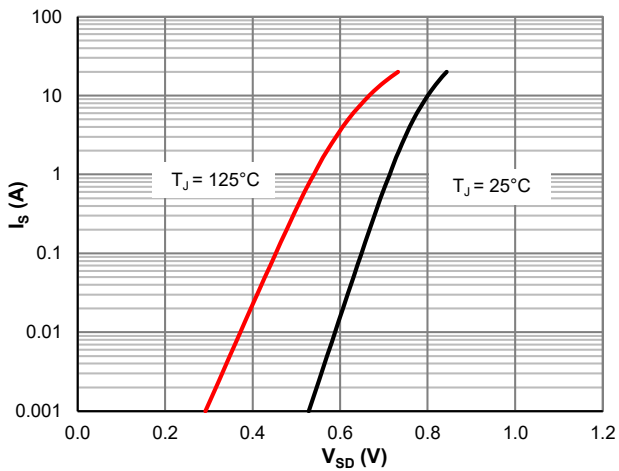


Figure 7: Body-Diode Characteristics

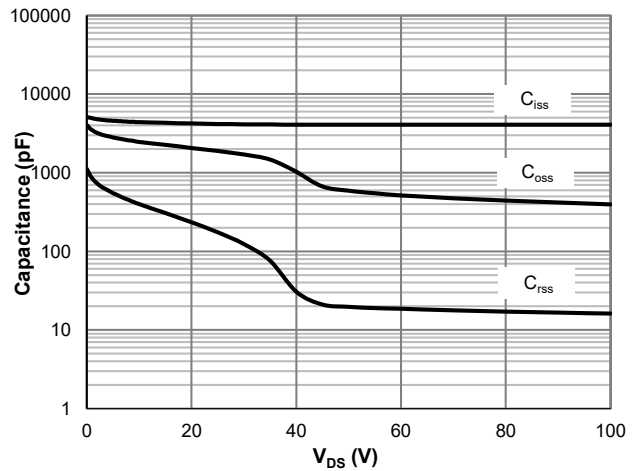


Figure 8: Capacitance Characteristics

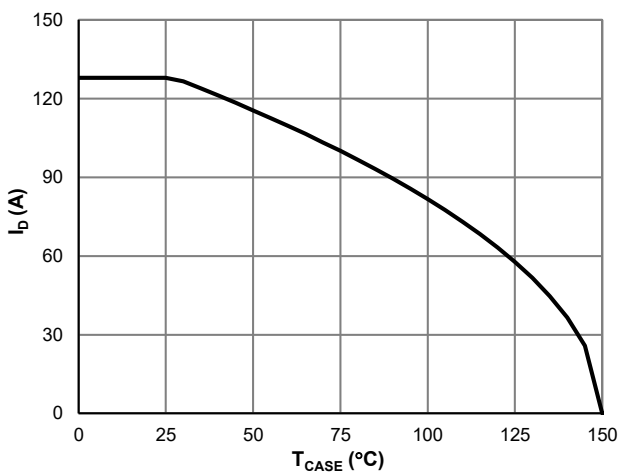


Figure 9: Current De-rating

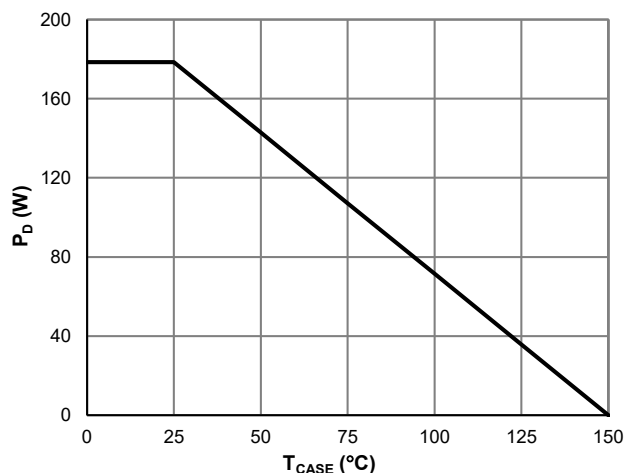


Figure 10: Power De-rating

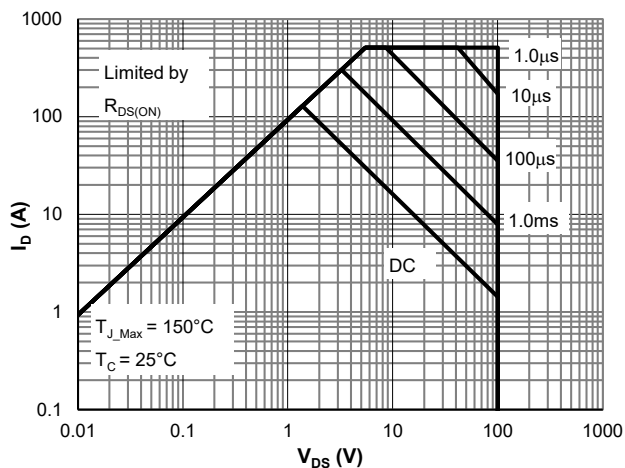


Figure 11: Maximum Safe Operating Area

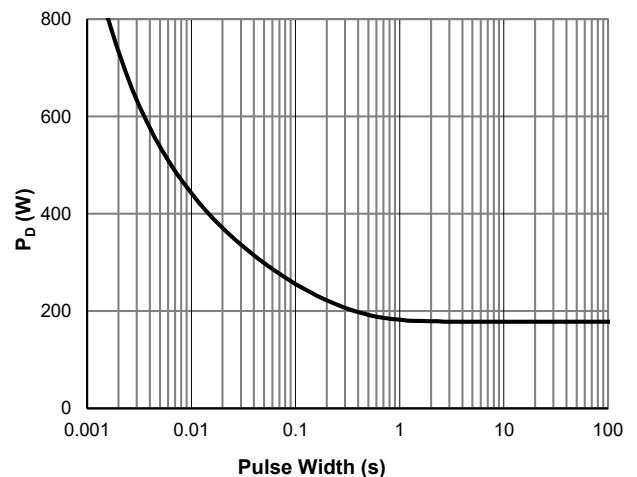


Figure 12: Single Pulse Power Rating, Junction-to-Case

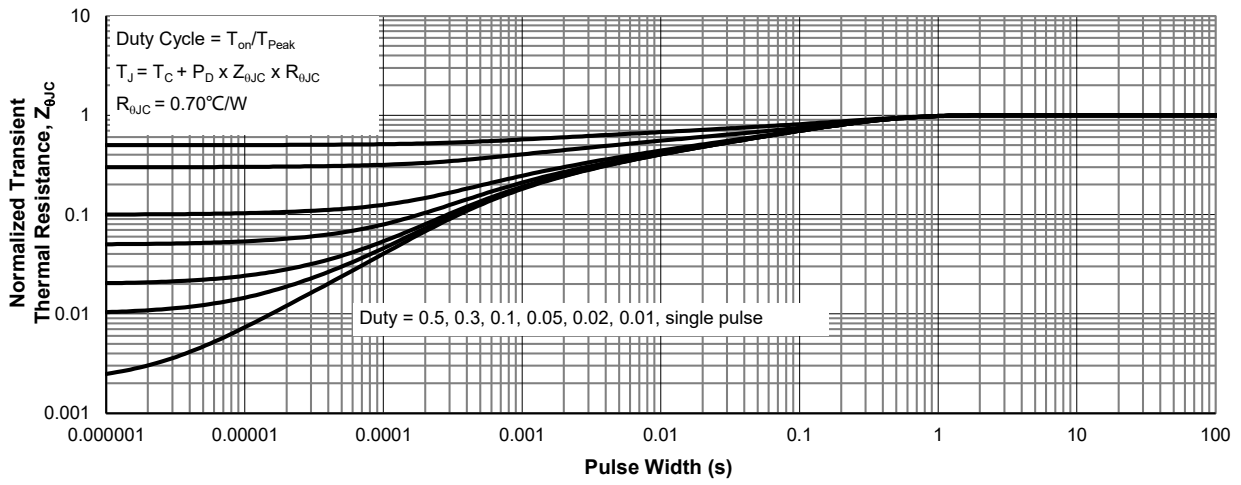
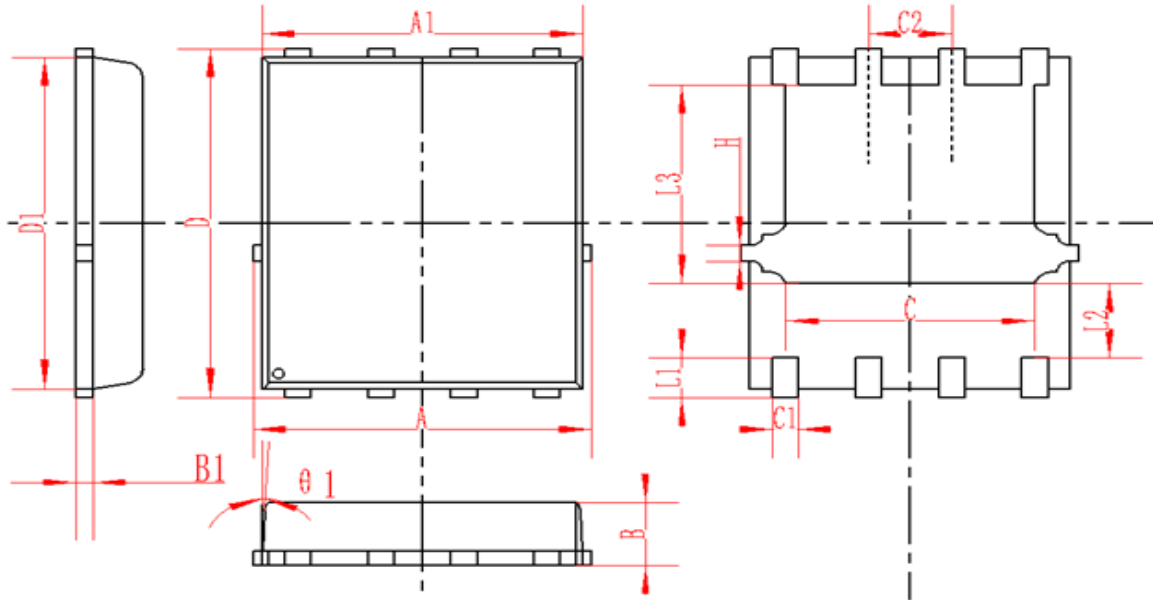


Figure 13: Normalized Maximum Transient Thermal Impedance



DFN5X6-8L Package Information



| SYMBOL | MM | | | INCH | | |
|--------|----------|------|-------|----------|-------|-------|
| | MIN | NOM | MAX | MIN | NOM | MAX |
| A | 4.95 | 5 | 5.05 | 0.195 | 0.197 | 0.199 |
| A1 | 4.82 | 4.9 | 4.98 | 0.190 | 0.193 | 0.196 |
| D | 5.98 | 6 | 6.02 | 0.235 | 0.236 | 0.237 |
| D1 | 5.67 | 5.75 | 5.83 | 0.223 | 0.226 | 0.230 |
| B | 0.9 | 0.95 | 1 | 0.035 | 0.037 | 0.039 |
| B1 | 0.254REF | | | 0.010REF | | |
| C | 3.95 | 4 | 4.05 | 0.156 | 0.157 | 0.159 |
| C1 | 0.35 | 0.4 | 0.45 | 0.014 | 0.016 | 0.018 |
| C2 | 1.27TYP | | | 0.5TYP | | |
| θ1 | 8° | 10° | 12° | 8° | 10° | 12° |
| L1 | 0.63 | 0.64 | 0.65 | 0.025 | 0.025 | 0.026 |
| L2 | 1.2 | 1.3 | 1.4 | 0.047 | 0.051 | 0.055 |
| L3 | 3.415 | 3.42 | 3.425 | 0.134 | 0.135 | 0.135 |
| H | 0.24 | 0.25 | 0.26 | 0.009 | 0.010 | 0.010 |



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